Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,621	SHIH ET AL.	
Examiner	Art Unit	_
Edna Wong	1753	

SEARCHED					
Class	Subclass	Date	Examiner		
106	1.26	1/18/2006	EW		
205	261	1/18/2006	EW		
205	296	1/18/2006	EW		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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DATE	
DATE	EXMR
1/18/2006	EW
1/18/2006	EW